

**International Journal of Current
Microbiology and Applied Sciences
(IJCMAS) NAAS RATING-5.38, ICV-95.39**
ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

An International, Monthly, Online, Free Access, Peer Reviewed,
Indexed, fast track Scientific Research Journal

Certificate of Publication

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2018.7.(5):905-911

<https://doi.org/10.20546/ijcmas.2018.705.110>

Comparative Study of Boron Accumulation in Flag Leaf, Spike and Grain of Wheat (*Triticum aestivum* L.) Grown under Heat Stress

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International Journal of Current Microbiology and Applied Sciences

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